

PMV56XN

μ TrenchMOS™ extremely low level FET

Rev. 02 — 24 June 2004

Product data

1. Product profile

1.1 Description

N-channel enhancement mode field-effect transistor in a plastic package using TrenchMOS™ technology.

1.2 Features

- TrenchMOS™ technology
- Low threshold voltage
- Very fast switching
- Subminiature surface mount package.

1.3 Applications

- Battery management
- High-speed switch
- Low power DC-to-DC converter.

1.4 Quick reference data

- $V_{DS} \leq 20$ V
- $I_D \leq 3.76$ A
- $P_{tot} \leq 1.92$ W
- $R_{DSon} \leq 85$ m Ω

2. Pinning information

Table 1: Pinning - SOT23, simplified outline and symbol

Pin	Description	Simplified outline	Symbol
1	gate (g)	<p>Top view MSB003</p> <p>SOT23</p>	<p>mbb076</p>
2	source (s)		
3	drain (d)		



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3. Ordering information

Table 2: Ordering information

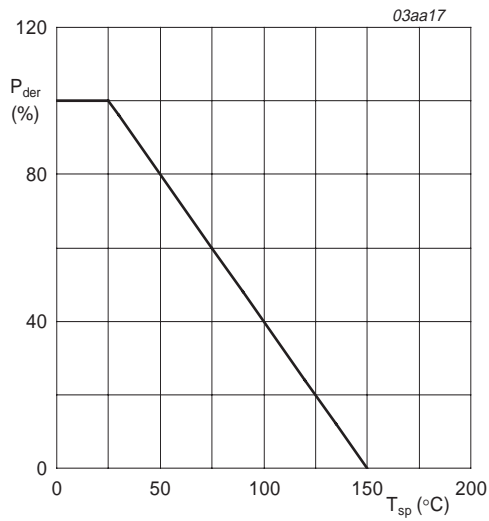
Type number	Package		
	Name	Description	Version
PMV56XN	SOT23	Plastic surface mounted package; 3 leads	SOT23

4. Limiting values

Table 3: Limiting values

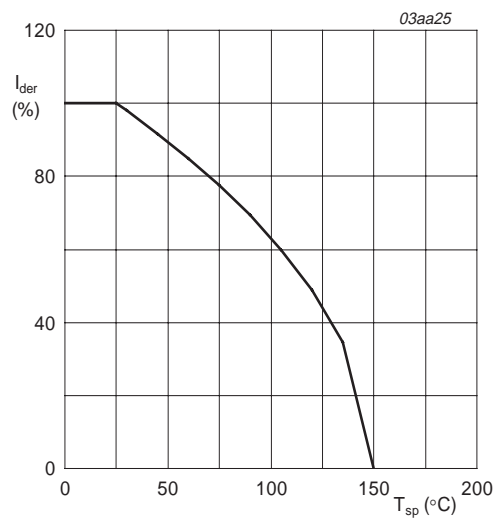
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage (DC)	$25\text{ °C} \leq T_j \leq 150\text{ °C}$	-	20	V
V_{GS}	gate-source voltage (DC)		-	± 8	V
I_D	drain current (DC)	$T_{sp} = 25\text{ °C}; V_{GS} = 4.5\text{ V};$ Figure 2 and 3	-	3.76	A
		$T_{sp} = 70\text{ °C}; V_{GS} = 4.5\text{ V};$ Figure 2	-	3	A
I_{DM}	peak drain current	$T_{sp} = 25\text{ °C};$ pulsed; $t_p \leq 10\text{ }\mu\text{s};$ Figure 3	-	15	A
P_{tot}	total power dissipation	$T_{sp} = 25\text{ °C};$ Figure 1	-	1.92	W
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-65	+150	°C
Source-drain diode					
I_S	source (diode forward) current (DC)	$T_{sp} = 25\text{ °C}$	-	1.6	A



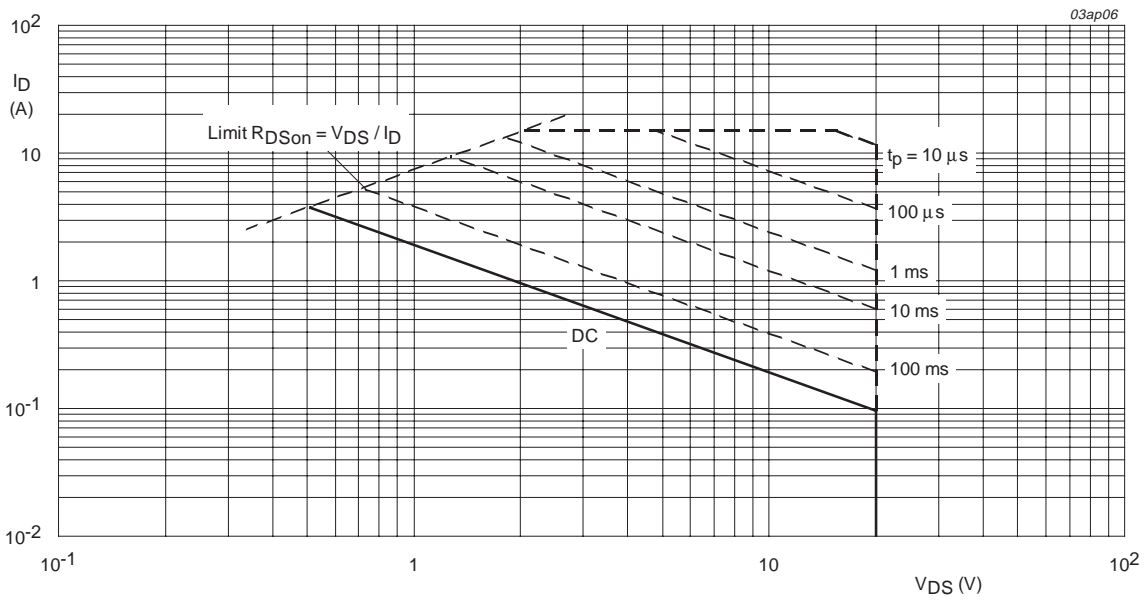
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of solder point temperature.



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of solder point temperature.



T_{sp} = 25 °C; I_{DM} is single pulse; V_{GS} = 4.5 V.

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	Figure 4	-	-	65	K/W

5.1 Transient thermal impedance

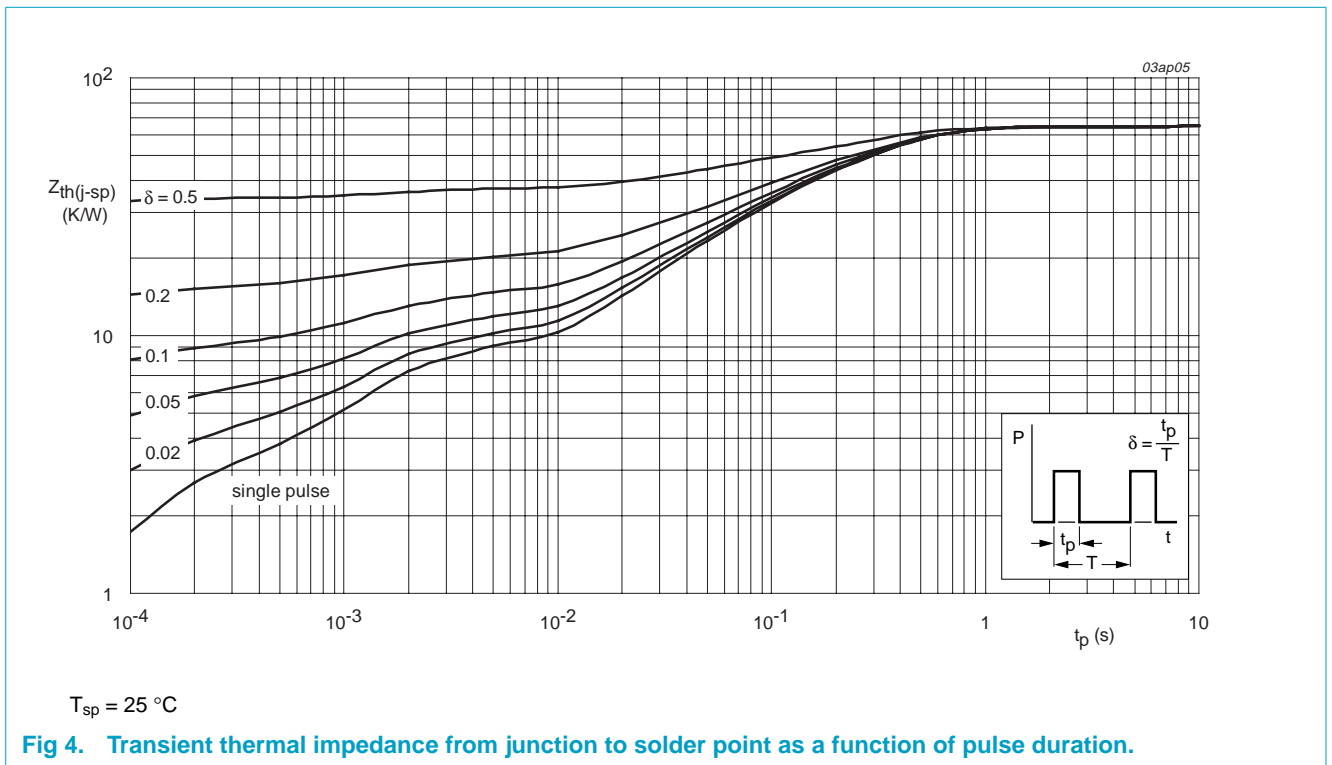


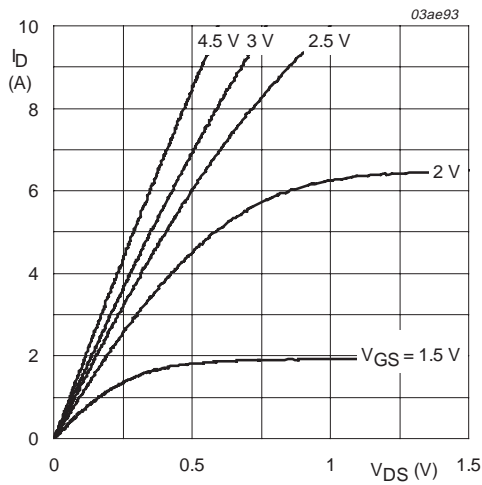
Fig 4. Transient thermal impedance from junction to solder point as a function of pulse duration.

6. Characteristics

Table 5: Characteristics

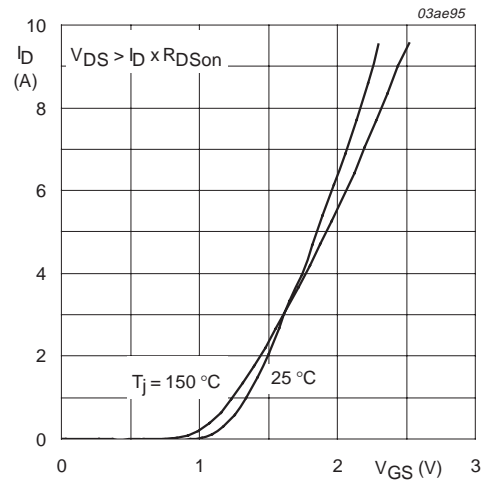
$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 10\text{ }\mu\text{A}; V_{GS} = 0\text{ V}$	20	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1\text{ mA}; V_{DS} = V_{GS}$; Figure 9	0.65	-	-	V
I_{DSS}	drain-source leakage current	$V_{DS} = 20\text{ V}; V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^\circ\text{C}$	-	0.01	1.0	μA
			-	-	10	μA
			-	-	-	-
I_{GSS}	gate-source leakage current	$V_{GS} = \pm 8\text{ V}; V_{DS} = 0\text{ V}$	-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5\text{ V}; I_D = 3.6\text{ A}$; Figure 7 and 8	-	56	85	$\text{m}\Omega$
		$V_{GS} = 2.5\text{ V}; I_D = 3.1\text{ A}$; Figure 7 and 8	-	77	115	$\text{m}\Omega$
Dynamic characteristics						
$Q_{g(tot)}$	total gate charge	$V_{DD} = 10\text{ V}; V_{GS} = 4.5\text{ V}; I_D = 3.6\text{ A}$; Figure 13	-	5.4	-	nC
Q_{gs}	gate-source charge		-	0.65	-	nC
Q_{gd}	gate-drain (Miller) charge		-	1.6	-	nC
C_{iss}	input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 10\text{ V}; f = 1\text{ MHz}$; Figure 11	-	230	-	pF
C_{oss}	output capacitance		-	125	-	pF
C_{rss}	reverse transfer capacitance		-	80	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DD} = 10\text{ V}; R_L = 5.5\text{ }\Omega; V_{GS} = 4.5\text{ V}; R_G = 6\text{ }\Omega$	-	12	-	ns
t_r	rise time		-	23	-	ns
$t_{d(off)}$	turn-off delay time		-	50	-	ns
t_f	fall time		-	34	-	ns
Source-drain diode						
V_{SD}	source-drain (diode forward) voltage	$I_S = 1.6\text{ A}; V_{GS} = 0\text{ V}$; Figure 12	-	0.8	1.2	V



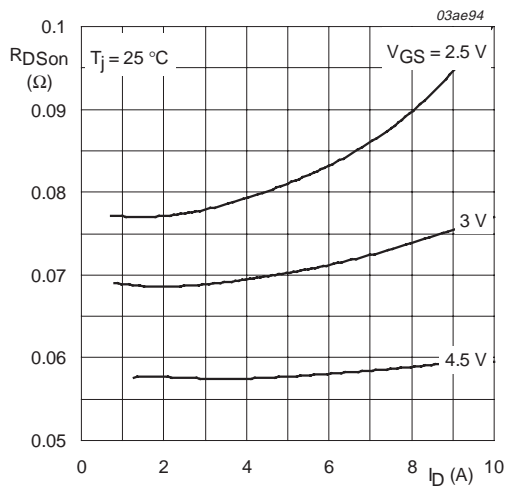
$T_j = 25\text{ °C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values.



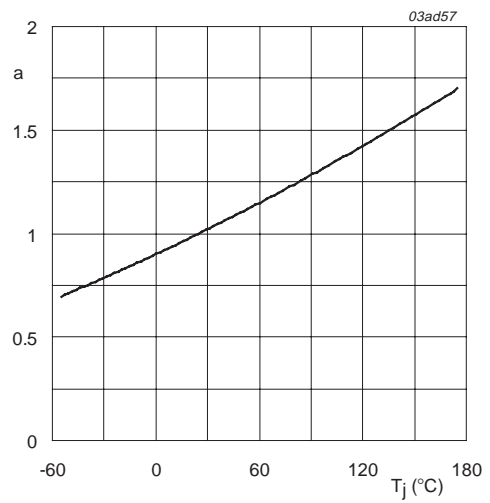
$T_j = 25\text{ °C}$ and 150 °C ; $V_{DS} > I_D \times R_{DSon}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values.



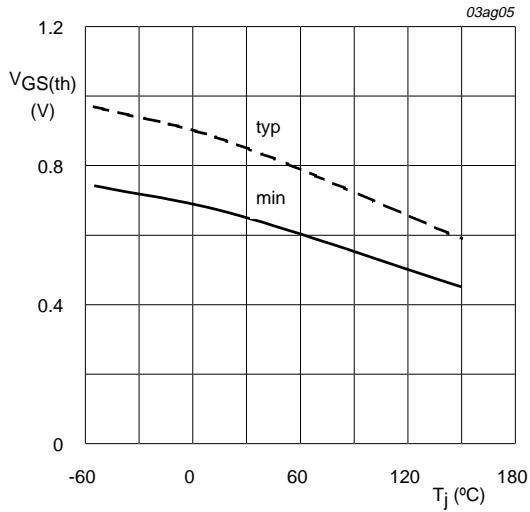
$T_j = 25\text{ °C}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values.



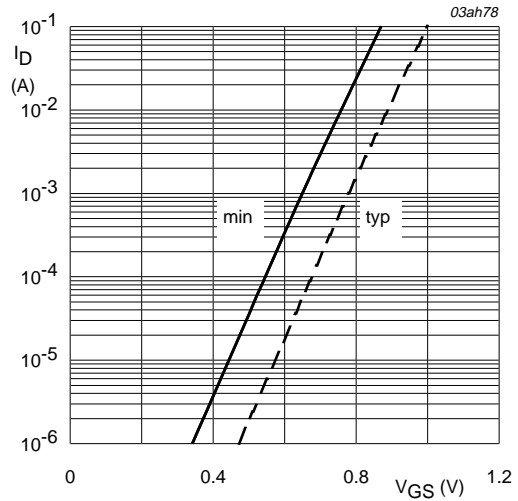
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature.



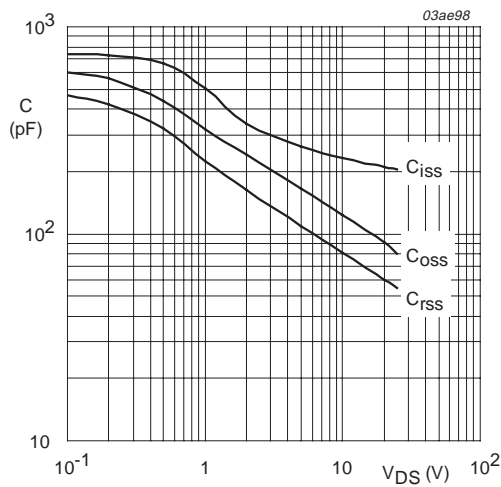
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature.



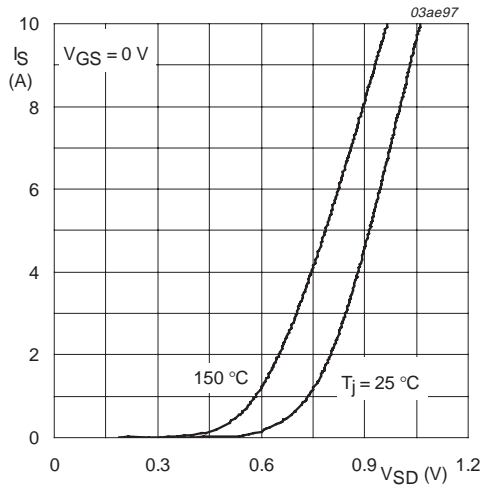
$T_j = 25 \text{ °C}; V_{DS} = 5 \text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage.



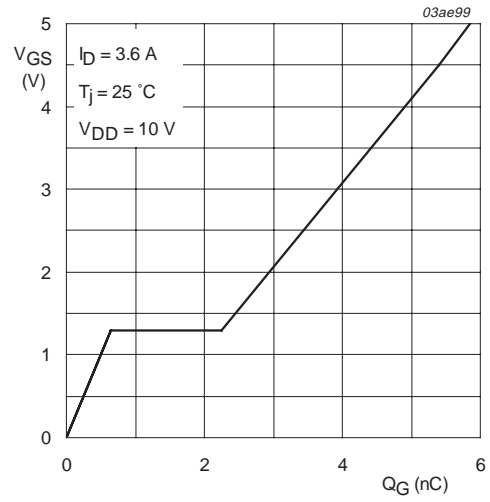
$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values.



$T_j = 25\text{ °C}$ and 150 °C ; $V_{GS} = 0\text{ V}$

Fig 12. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values.



$I_D = 3.6\text{ A}$; $V_{DD} = 10\text{ V}$

Fig 13. Gate-source voltage as a function of gate charge; typical values.

7. Package outline

Plastic surface mounted package; 3 leads

SOT23

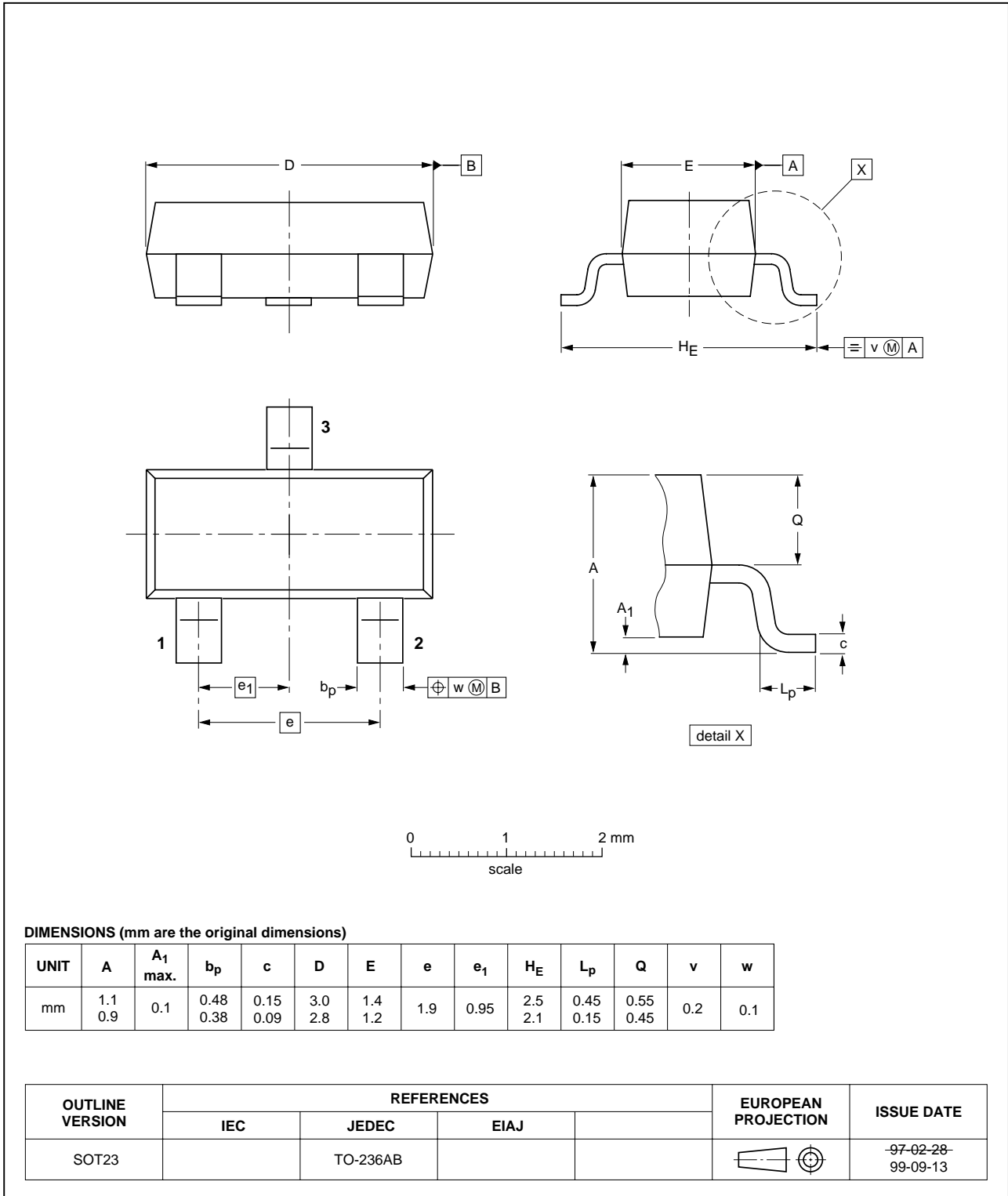


Fig 14. SOT23.

8. Revision history

Table 6: Revision history

Rev	Date	CPCN	Description
02	20040624	-	Product data (9397 750 13495) Modifications: <ul style="list-style-type: none">• Updated to latest standards.• Section 1.4 “Quick reference data” I_D and P_{tot} increased.• Section 4 “Limiting values” I_D, I_{DM}, P_{tot} and I_S increased.• Section 4 “Limiting values” Figure 3 modified.• Section 5 “Thermal characteristics” Figure 4 modified.
01	20030226	-	Product data (9397 750 11096).

9. Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2][3]}	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Contents

1	Product profile	1
1.1	Description	1
1.2	Features	1
1.3	Applications	1
1.4	Quick reference data	1
2	Pinning information	1
3	Ordering information	2
4	Limiting values	2
5	Thermal characteristics	4
5.1	Transient thermal impedance	4
6	Characteristics	5
7	Package outline	9
8	Revision history	10
9	Data sheet status	11
10	Definitions	11
11	Disclaimers	11
12	Trademarks	11

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